USB-1808X

Eight-Channel Simultaneous-Sampling Multifunction Device

User's Guide



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Table of Contents

Pretace About this User's Guide	5
What you will learn from this user's guide	
Conventions in this user's guide	
Where to find more information	
Chapter 1	
Introducing the USB-1808X	6
Functional block diagram	6
Chapter 2 Installing the USB-1808X	7
Unpacking	7
Installing the software	7
Installing the hardware	7
Calibrating the hardware	7
Updating firmware	7
Chapter 3	
Functional Details	8
External components	
USB connector Screw terminals	
LEDs	
Analog input	10
Channel-Gain queue	
Analog output	
Digital I/O Digital input scanning	
Pull-up/down configuration	
Counter input	
Totalize counter mode	
Period measurement mode	
Quadrature encoder input	
Timer output	
Synchronous I/O – mixing analog, digital, and counter scanning	
Clock I/O	
Digital triggering	
Pattern triggering	
Mask option	
Ground	16
Power output	16
Mechanical drawings	17
Chapter 4	
Specifications	
Analog input	
Analog input DC voltage messurement accuracy	
Analog input DC voltage measurement accuracy Dynamic performance	

Noise performance	19
Analog output	20
Analog input/output calibration	21
Digital input/output	21
Counter	
Timer	23
External clock input/output.	23
External trigger	24
Pattern trigger	24
Memory	24
Power	24
USB	25
Environmental	25
Mechanical	25
Screw terminal connector Differential mode pinout Single-ended mode pinout	26
EU Declaration of Conformity	28

About this User's Guide

What you will learn from this user's guide

This user's guide describes the Measurement Computing USB-1808X data acquisition device and lists device specifications.

Conventions in this user's guide

For more information

Text presented in a box signifies additional information and helpful hints related to the subject matter you are reading.

Caution! Shaded caution statements present information to help you avoid injuring yourself and others, damaging your hardware, or losing your data.

Bold text is used for the names of objects on a screen, such as buttons, text boxes, and checkboxes.

Italic text is used for the names of manuals and help topic titles, and to emphasize a word or phrase.

Where to find more information

Additional information about USB-1808X hardware is available on our website at www.mccdaq.com. You can also contact Measurement Computing Corporation with specific questions.

- Knowledgebase: <u>kb.mccdaq.com</u>
- Tech support form: www.mccdaq.com/support/support form.aspx
- Email: techsupport@mccdaq.com
- Phone: 508-946-5100 and follow the instructions for reaching Tech Support

For international customers, contact your local distributor. Refer to the International Distributors section on our web site at www.mccdaq.com/International.

Introducing the USB-1808X

The USB-1808X is a multifunction data acquisition device providing the following features:

- Eight 18-bit simultaneous-sampling differential (DIFF) or single-ended (SE) analog input channels software-selectable per channel as DIFF or SE
- Sample rate of 200 kS/s per channel maximum
- Analog input ranges of $\pm 10 \text{ V}$, $\pm 5 \text{ V}$, 0 V to 10 V, and 0 V to 5 V software-selectable per channel
- Two 16-bit analog outputs
- Four individually-configurable digital I/O channels
- Two high-speed general-purpose counters
- Two quadrature encoder inputs
- Two timer outputs
- One external digital trigger for data acquisition and one external digital trigger for data generation
- Two external clock inputs and two clock outputs for synchronous input and output operations with more than one device.
- Screw terminals for field wiring connections

The device is powered by the +5 V USB supply from the computer, requiring no external power.

The USB-1808X is a USB 2.0 high-speed device that is fully compatible with both USB 1.1, USB 2.0, and USB 3.0 ports.

Functional block diagram

USB-1808X functions are illustrated in the block diagram shown here.

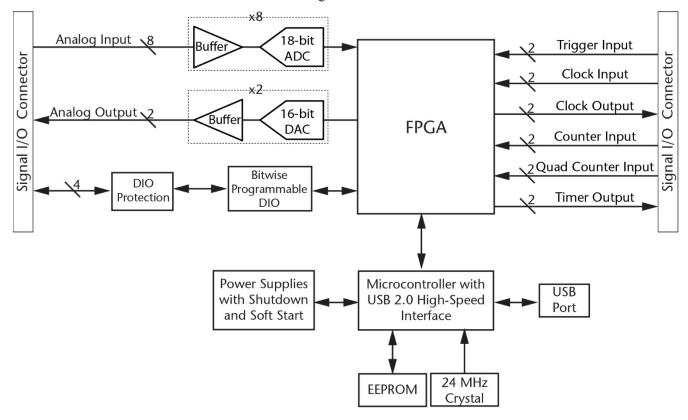


Figure 1. Functional block diagram

Installing the USB-1808X

Unpacking

As with any electronic device, you should take care while handling to avoid damage from static electricity. Before removing the device from its packaging, ground yourself using a wrist strap or by simply touching the computer chassis or other grounded object to eliminate any stored static charge.

Contact us immediately if any components are missing or damaged.

Installing the software

Refer to the MCC DAQ Quick Start and the USB-1808X product page on our website for information about the software supported by the USB-1808X.

Install the software before you install your device

The driver needed to run the USB-1808X is installed with the software. Therefore, you need to install the software package you plan to use before you install the hardware.

Installing the hardware

To connect the USB-1808X to your system, connect the USB cable to an available USB port on the computer or to an external USB hub connected to the computer. Connect the other end of the USB cable to the USB connector on the device. No external power is required.

When connected for the first time, a **Found New Hardware** dialog opens when the operating system detects the device. When the dialog closes, the installation is complete. The **Status** LED on the USB-1808X turns on after the device is successfully installed.

If the Status LED turns off

If communication is lost between the device and the computer, the device LED turns off. To restore communication, disconnect the USB cable from the computer and then reconnect it. This should restore communication, and the LED should turn on.

Calibrating the hardware

The Measurement Computing Manufacturing Test department performs the initial factory calibration. Return the device to Measurement Computing Corporation when calibration is required. The recommended calibration interval is one year.

Updating firmware

Your DAQ device contains firmware that can be updated in the field if required. Firmware is available for download at www.mccdaq.com/firmware.aspx. MCC recommends that you check this page periodically to see if an update to your device firmware is available.

Functional Details

External components

The USB-1808X has the following external components (see Figure 2 through Figure 4 on pgs. 9-10):

- USB connector
- LEDs
- Screw terminals

USB connector

The USB connector provides +5 V power and communication. No external power supply is required.

Screw terminals

The screw terminals provide the following connections:

- Eight DIFF analog inputs (CH0H/CH0L to CH7H/CH7L) or eight SE analog inputs (CH0H to CH7H) Refer to Figure 2 and Figure 3 on page 9 for DIFF and SE pinouts.
- Two analog outputs (AOUT0 and AOUT1)
- Four digital I/O lines (**DIO0** to **DIO3**)
- Two general-purpose counter inputs (CTR0 and CTR1)
- Two quadrature encoder inputs (ENC0A, ENC0B, ENC0Z and ENC1A, ENC1B, ENC1Z)
- Two timer outputs (**TMR0** and **TMR1**)
- An external trigger input (ITRIG) and an external trigger output OTRIG)
- Two external clock inputs (ICLKI and OCLKI) and two external clock outputs (ICLKO, OCLKO)
- One +5 V power output (**+VO**) connection
- Ten analog ground (AGND) and seven digital ground (GND) connections

Use 16 AWG to 30 AWG wire when making connections to the screw terminals.

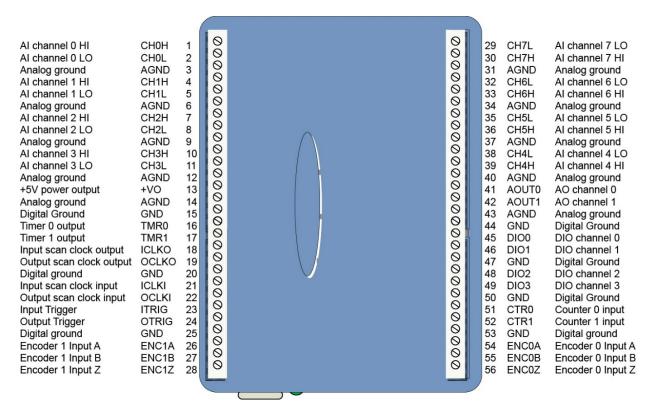


Figure 2. DIFF mode pinout

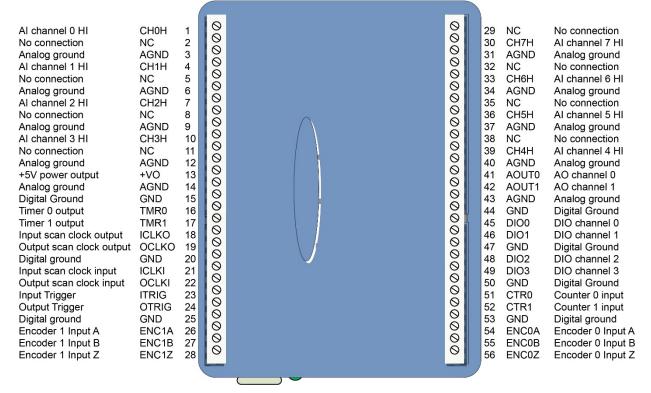


Figure 3. SE mode pinout

LEDs

The USB-1808X has two LED indicators that indicate the status of power and data. The LEDs are stacked one above the other, as shown in Figure 4.

- The **Status** LED turns on when the device is detected by the computer.
- The **Activity** LED blinks when data is transferred and is off otherwise.

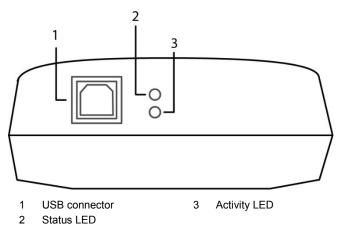


Figure 4. LED indicators

Analog input

You can configure each analog input channel for either SE or DIFF mode. MCC recommends connecting unused analog input terminals to analog ground terminals during operation. For example, if you are not using **CH7L**, connect this terminal to an available **AGND** terminal.

The input voltage range is software-selectable per channel for $\pm 10 \text{ V}$, $\pm 5 \text{ V}$, 0 V to 10 V, or 0 V to 5 V.

Analog input operations can be paced by the internal clock or by an external clock (**ICLKI** – refer to *Clock I/O* on page 15). They can be initiated by a digital trigger (*Digital triggering* on page 15) or a pattern trigger (*Pattern triggering* on page 15).

Refer to *Synchronous I/O – mixing analog, digital, and counter scanning* on page 15 for information on running analog input scans at the same time as other subsystem scans.

For more information about analog signal connections

For more information about analog input connections, refer to the *Guide to DAQ Signal Connections* (available for download at www.mccdaq.com/support/DAQ-Signal-Connections.aspx).

Channel-Gain queue

The channel-gain queue feature allows you to configure a different gain setting for each channel. The gain settings are stored in a channel-gain queue list that is written to local memory on the device.

The channel-gain queue list can contain up to eight unique elements. The channel list must be in increasing order. An example of a five-element list is shown in the following table.

Element	Channel	Range
0	CH0H/CH0L (DIFF)	±10 V
1	CH2H/AGND (SE)	±5 V
2	CH3H/AGND (SE)	0 V to 5 V
3	CH6H/CH6L (DIFF)	0 V to 10 V
4	CH7H/CH7L (DIFF)	±5 V

Sample channel-gain queue list

Carefully match the gain to the expected voltage range on the associated channel or an over range condition may occur. Although this condition does not damage the device, it does produce a useless full-scale reading, and can introduce a long recovery time due to saturation of the input channel.

Analog output

The two 16-bit analog outputs (AOUT0 and AOUT1) can be updated simultaneously at a rate of 500 kS/s per channel. Each output can be updated at a rate of 500 kS/s. The output range is fixed at ± 10 V. The outputs default to 0 V at power up, or when a reset command is issued to the device.

Analog output operations can be paced by the internal clock or by an external clock (**OCLKI** – refer to Clock I/O on page 15). They can be initiated by a digital trigger (*Digital triggering* on page 15) or a pattern trigger (*Pattern triggering* on page 15).

Refer to *Synchronous I/O – mixing analog, digital, and counter scanning* on page 15 for information on running analog output scans at the same time as other subsystem scans.

Digital I/O

You can connect up to four digital I/O lines to **DIOO** through **DIO3**. Each digital channel is individually configurable for input or output. During initial power on or reset, the digital pins are set for input.

The digital I/O terminals can detect the state of any TTL-level input. Refer to the schematic shown in Figure 5.

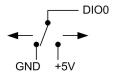


Figure 5. Schematic showing switch detection by digital channel DIO0

If you set the switch to the +5 V input, DIO0 reads TRUE (1). When set to GND, DIO0 reads FALSE (0).

Digital input scanning

Digital input operations can be paced by the internal clock or by an external clock (**ICLKI** – refer to *Clock* I/O on page 15). They can be initiated by a digital trigger (*Digital triggering* on page 15) or a pattern trigger (*Pattern triggering* on page 15).

If no analog inputs are being scanned, the digital inputs can sustain rates up to 200 kHz. Digital input ports can also be read asynchronously before, during, or after an analog input scan.

Refer to *Synchronous I/O – mixing analog, digital, and counter scanning* on page 15 for information on running digital input scans at the same time as other subsystem scans.

Pull-up/down configuration

All digital I/O lines are pulled down to 0 V (LO) with a 47 k Ω resistor (default). You can change the pull-up/down configuration using the internal jumper labeled **DIO**. You must remove the device housing to access the jumper on the circuit board.

To set the jumper for pull-up or pull-down, complete the following steps.

- 1. Unplug the device from the computer.
- 2. Turn the device over and rest the top of the housing on a flat, stable surface.

Caution! The discharge of static electricity can damage some electronic components. Before removing the USB-1808X from its housing, ground yourself using a wrist strap or touch the computer chassis or other grounded object to eliminate any stored static charge.

3. Remove the rubber fee from the bottom of the device, and the four screws using a #1 Philips head screwdriver.

4. Hold both the top and bottom sections together, turn the device over and rest it on the surface, then carefully remove the top section of the case to expose the circuit board.

Figure 6 shows the location of the **DIO** jumper on the circuit board.

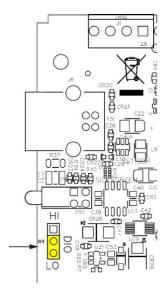


Figure 6. Pull-up/down jumper location

5. Configure the **DIO** jumper for pull-up or pull-down, as shown in Figure 7.

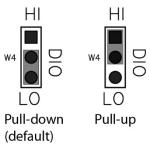


Figure 7. Pull-up/down jumper configuration

6. Replace the top section of the housing and fasten it to the bottom section with the four screws.

For more information about digital signal connections

For general information about digital signal connections and digital I/O techniques, refer to the *Guide to DAQ Signal Connections* (available for download at www.mccdaq.com/support/DAQ-Signal-Connections.aspx).

Counter input

Counter inputs can be read asynchronously under program control, or synchronously as part of a digital scan group.

The **CTR0** and **CTR1** terminals are 32-bit general-purpose counters that can accept frequency inputs up to 50 MHz.

The USB-1808X supports the following counter input modes:

- Totalize
- Period measurement
- Pulse-width measurement

Counter input modes are programmable with software. Each mode supports additional counter operation options.

Typically, when data is acquired with no counter operation options set, the count of each counter channel is set to 0 and latched at the beginning of the acquisition.

When counter options are set the counters can concurrently monitor time periods, frequencies, pulses, and other event-driven incremental occurrences directly from pulse-generators, limit switches, proximity switches, and magnetic pick-ups.

Counter input operations can be paced by the internal clock or by an external clock (**ICLKI** – refer to *Clock I/O* on page 15). They can be initiated by a digital trigger (*Digital triggering* on page 15) or a pattern trigger (*Pattern triggering* on page 15).

Refer to *Synchronous I/O – mixing analog, digital, and counter scanning* on page 15 for information on running counter input scans at the same time as other subsystem scans.

Totalize counter mode

The USB-1808X can be used as a high-speed pulse counter for general counting applications. The internal counter increments when the TTL levels transition from low to high or from high to low.

Each option supported in Totalize mode is explained in following table:

Counter option	Description
Clear on read	The counter is cleared after each read (synchronous or asynchronous). The value of the counter before it was cleared is latched and returned.
Range limit	When counting up: The counter rolls over to MINLIMIT (or stops if Non-recycle is set) when the maximum count (specified by the MAXLIMIT value) is reached. When counting down: The counter counts down to MINLIMIT and then rolls over to MAXLIMIT (or stops if Non-recycle is set).
Non-recycle	The counter stops if a count overflow or underflow occurs (or, if Range limit is set, the MAXLIMIT or MINLIMIT value is reached). Counting resumes if direction is reversed or the counter is reloaded.

Period measurement mode

Use period mode to measure the period of a signal at a counter channel's input. You can measure x1, x10, x100 or x1000 periods for 32-bit values. Four resolutions are available — 20 ns, 200 ns, 2000 ns, or 20,000 ns. All period measurement mode options are software-selectable. The 100 MHz system clock is used as the timing source. Periods from sub-microsecond to many seconds can be measured.

Pulse width measurement mode

Use pulse width mode to measure the time from the rising edge to the falling edge, or vice versa, on a counter input signal. Four resolutions are available — 20 ns, 200 ns, 2000 ns, or 20,000 ns. All pulse width measurement mode options are software selectable. The 100 MHz system clock is used as the timing source. Pulse widths from sub-microsecond to many seconds can be measured.

Quadrature encoder input

The USB-1808X can simultaneously decode signals from up to two encoders. Quadrature encoders, 50 MHz maximum pulse frequency, and X1, X2, and X4 count modes are supported.

The USB-1808X provides A, B, and Z inputs – ENCxA, ENCxB, and ENCxZ – for each connected encoder. A typical encoder generates the A and B signals at a 90° phase shift with respect to each other. These signals are used to determine system position (counts), velocity (counts per second), and direction of travel or rotation. The Z signal can be programmed to latch the current count or reload the counter with the MINLIMIT value (counting up) or the MAXLIMIT value (counting down).

The Z signal may be used to establish an absolute reference position within one count of the encoder travel or rotation. This signal can be used to reload the position counter, which is useful at system startup when the incremental encoder cannot determine the starting position.

Encoder input operations can be paced by the internal clock or by an external clock (**ICLKI** – refer to *Clock I/O* on page 15). They can be initiated by a digital trigger (*Digital triggering* on page 15) or a pattern trigger (*Pattern triggering on page 15*).

Refer to *Synchronous I/O – mixing analog, digital, and counter scanning* on page 15 for information on running quadrature encoder scans at the same time as other subsystem scans.

Each supported quadrature encoder option is explained in following table:

Quadrature encoder options

Encoder option	Description
Count mode	Select X1, X2, or X4. Count modes provide different levels of accuracy with respect to the encoder position. X1: counts rising edges on input A. X2: counts rising edges and falling edges on input A. X4: count rising and falling edges on both inputs A and B.
Range limit	When counting up: The counter stops when the maximum count (specified by the MAXLIMIT value) is reached. Counting resumes if direction is reversed or the counter is cleared. When counting down: The counter stops when the minimum count (specified by the MINLIMIT value) is reached. Counting resumes if direction is reversed or the counter is cleared.

Quadrature encoder options that are specific to the Z signal (ENCxZ) are is explained in following table.

Z input quadrature encoder options ()

Counter mode	Description	
Clear on Z	The counter is cleared by the Z signal.	
Latching	Latching mode allows the count to be latched by the Z signal.	

Timer output

You can use **TMR0** through **TMR1** as 32-bit timer outputs. Each timer can generate pulse rates of up to 50 MHz, with programmable pulse widths down to 10 ns.

The timer output rate and pulse width can be updated asynchronously at any time, however, doing so results in a pulse stream that is not seamless.

The following timer output options are software-selectable:

- pulse frequency
- duty cycle (pulse width divided by the pulse period)
- number of pulses to generate
- time delay before starting the timer output after it is enabled
- idle state of the output (idle high or idle low)

The time delay can range from 0 seconds to 42.94 seconds.

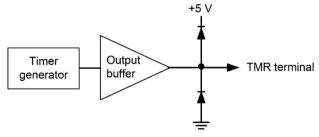


Figure 8. USB-1808X PWM timer channel

Timer output operations can be paced by the internal clock or by an external clock (**OCLKI** – refer to *Clock I/O* on page 15). They can be initiated by a digital trigger (*Digital triggering* on page 15).

Synchronous I/O – mixing analog, digital, and counter scanning

The USB-1808X can read analog, digital, and counter inputs, and generate up to two analog outputs and one digital pattern output at the same time. Digital and counter inputs do not affect the overall A/D rate because these inputs use no time slot in the scanning sequencer.

For example, one analog input channel can be scanned at the full 200 kS/s A/D rate along with digital and counter input channels. Each analog channel can have a different gain, and counter and digital channels do not need additional scanning bandwidth if there is at least one analog channel in the scan group. Digital input channel sampling is done during the *dead time* of the scan period when no analog sampling is being done.

Clock I/O

The USB-1808X provides one external clock input (ICLKI) and one clock output (ICLKO) for input operations.

- Connect an external clock signal to ICLKI.
- The pacer clock is available at ICLKO.

The USB-1808X provides one external clock input (**OCLKI**) and one clock output (**OCLKO**) for output operations.

- Connect an external clock signal to OCLKI.
- The pacer clock is available at **OCLKO**.

Digital triggering

The **ITRIG** (for triggering input operations) and **OTRIG** (for triggering output operations) terminals are external digital trigger inputs. The trigger mode is software-selectable for edge or level sensitive. Edge sensitive mode is selectable for rising or falling. Level sensitive mode is selectable for high or low.

Pattern triggering

You can also start an input or output scan with a digital pattern trigger using DIO0 – DIO3. The pattern represents the state of up to four bits on the port.

You specify the pattern and the trigger type with software. Supported trigger types are Above Pattern, Below Pattern, Equal Pattern, and Not Equal Pattern. The scan begins when the trigger conditions are met.

The base clock is fixed at 100 MHz (10 ns). The trigger pattern must be held for five base clock cycles (50 ns) to ensure that it is properly detected. The trigger latency is 1 scan clock period + 8 base clock cycles (80 ns).

Mask option

Use a bitmask to specify which bits to include or exclude from the pattern to detect. To include a bit in the pattern, sets its value to 1. To exclude a bit from the pattern, sets its value to 0. Refer to the pattern and mask values shown in Figure 9 and Figure 10.

In Figure 9 all mask bits are set to 1, so all the bits are included in the pattern to detect.

Figure 9. Trigger mask with all bits included

In Figure 10 all mask bits are excluded except bit 3. The result of this operation is that only bit 3 is included in the pattern to detect.

Figure 10. Trigger mask with some bits excluded

Ground

The analog ground (AGND) terminals provide a common ground for all analog channels.

The digital ground (GND) terminals provide a common ground for the digital, trigger, counter, and encoder terminals.

Power output

The **+VO** terminal can output up to 10 mA maximum. You can use this terminal to supply power to external devices or circuitry.

Mechanical drawings

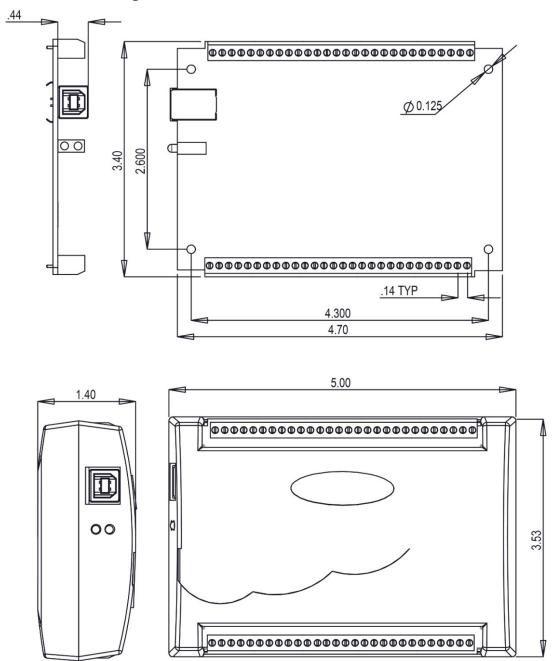


Figure 11. USB-1808X circuit board (top) and enclosure dimensions

Specifications

All specifications are subject to change without notice. Typical for 25 °C unless otherwise specified. Specifications in *italic* text are guaranteed by design.

Analog input

Table 1. General analog input specifications

Parameter	Condition	Specification
A/D converter type		Simultaneous
ADC resolution		18 bits
Number of channels		8 differential (DIFF), 8 single-ended (SE); software-selectable per-channel for SE or DIFF
Input voltage range		±10 V, ±5 V, 0 V to 10 V, 0 V to 5 V Software-selectable per channel
Absolute max input voltage	CHx relative to AGND	■ ±25 V max (power on) ■ ±15 V max (power off)
Input impedance		■ >1 GΩ (power on) ■ 1000 Ω (power off)
Input bias current		±50 pA
Input bandwidth	All input ranges, small signal (-3 dB)	2.0 MHz
Input capacitance		50 pf
Common mode voltage	±10 V range	±10.1 V
range	±5 V range	±10.1 V
	0 V to 10 V range	±10.1 V
	0 V to 5 V range	±10.1 V
Common mode rejection ratio	$f_{\rm IN} \le 1$ kHz, all input ranges	90 dB
Crosstalk	±10 V, adjacent channels, DC to 100 kHz	-95 dB
Input coupling		DC
Sample rate		0.023 Hz to 200 kHz; software-selectable
Scan clock source		Internal input scan clock or external input scan clock (ICLKI pin)
Trigger source		 ITRIG (see External trigger on page 24) Digital pattern detection (see Pattern trigger on page 24)
Channel gain queue	Up to 8 elements	Software-selectable. Queue list may contain up to eight elements of unique, consecutive channels paired with any valid range.
Warm-up time		15 minutes min

Accuracy

Analog input DC voltage measurement accuracy

Table 2. DC accuracy components and specifications. All values are (±)

Range	Gain error (% of reading)	Offset error (mV)	INL error (% of range)	Absolute accuracy at Full Scale (mV)	Gain temperature coefficient (% reading/°C)	Offset temperature coefficient (µV/°C)
±10 V	0.020	1.5	0.00076	3.576	0.00023	4
±5 V	0.020	1.0	0.00057	2.028	0.00023	4
0 V to 10 V	0.020	1.5	0.00028	3.528	0.00023	4
0 V to 5 V	0.020	1.0	0.00014	2.007	0.00023	4

Dynamic performance

Table 3. Dynamic performance specifications

Range	Condition	Specification
	Signal-to-noise ratio (SNR)	94 dB
	Signal-to-noise-and-distortion ratio (SINAD)	94 dB
±10 V	Total harmonic distortion (THD)	-108 dB
	Spurious free dynamic range (SFDR)	112 dB
	Effective number of bits (ENOB)	15.3 bits
	SNR	91 dB
	SINAD	91 dB
±5 V	THD	-105 dB
	SFDR	107 dB
	ENOB	14.8 bits
	SNR	87 dB
	SINAD	87 dB
0 V to 10 V	THD	-104 dB
	SFDR	109 dB
	ENOB	14.5 bits
	SNR	83 dB
	SINAD	83 dB
0 V to 5 V	THD	-103 dB
	SFDR	103 dB
	ENOB	13.6 bits

Noise performance

For the peak-to-peak noise distribution test, a differential input channel is connected to AGND at the input terminal block, and 32,000 samples are acquired at the maximum rate available at each setting.

Table 4. Noise performance specifications

Range	Counts	LSBrms
±10 V	11.6	1.77
±5 V	18.0	2.73
0 V to 10 V	23.3	3.54
0 V to 5 V	36.1	5.47

Analog output

Table 5. Analog output specifications

Parameter	Condition	Specification
Number of channels		2
Resolution		16 bits
Output ranges	Calibrated	±10 V
Output transient	Host computer is reset, powered on, suspended, or a reset command is issued to the device	Duration: 5 ms Amplitude: 2 V p-p
	Powered off from 0 V output	Duration: 20 ms Amplitude: 5 V p-p
Differential non-linearity		±0.25 LSB typ ±1 LSB max
Output current	AOUTx pins	±3.5 mA max
Output short-circuit protection	Single AOUTx channel connected to AGND	Unlimited duration
Output coupling		DC
Power on and reset state		DACs cleared to zero-scale: 0 V, ±50 mV
Output noise		100 μVrms
Trigger source		 OTRIG (see External trigger on page 24) Digital pattern detection (see Pattern trigger on page 24)
Scan clock source		Internal output scan clock or external output scan clock (OCLKI pin)
Output update rate		0.023 Hz to 500 kHz per channel
Slew rate		15 V/μS
Throughput	Software paced	33 S/s to 8,000 S/s typ, system-dependent
	Hardware paced	1,000 kS/s max, system-dependent

Note 1: Leave unused AOUTx output channels disconnected.

Note 2: AOUTx defaults to 0 V whenever the host computer is reset, powered on, suspended, or a reset command is issued to the device.

Table 6. Calibrated absolute accuracy specifications

Range	Absolute accuracy (±LSB)
±10 V	16

Table 7. Calibrated absolute accuracy components specifications

Range	% of reading	Offset (±mV)	Offset tempco (μV/°C)	Gain tempco (ppm of range/°C)
±10 V	0.0183	1.831	4.7	9.4

Table 8. Relative accuracy specifications (±LSB)

Range	Relative accuracy (INL)
±10 V	1.0

Analog input/output calibration

Table 9. Analog I/O calibration specifications

Parameter	Specification
Warm-up time	15 minutes recommended min
Calibration method	Factory calibration
Calibration interval	1 year

Digital input/output

Table 10. Digital I/O specifications

Parameter	Specification	
Digital type	CMOS	
Number of I/O	4	
Configuration	Each bit may be configured as input (power on default) or output	
Pull-up configuration	The port has 47 k Ω resistors configurable as pull-up or pull-down (default) via internal jumper (DIO).	
Digital I/O transfer rate (system-paced, asynchronous)	33 to 8,000 port reads/writes or single bit reads/writes per second typ, system dependent.	
Digital I/O transfer rate (synchronous)	0.023 Hz to 200 kHz input, 500 kHz output, based on the internal clock speed of 100 MHz	
Scan clock source for input	Internal input scan clock or external input scan clock (ICLKI pin)	
Scan clock source for input	Internal output scan clock or external output scan clock (OCLKI pin)	
Trigger source	■ ITRIG for inputs, OTRIG for outputs (see <i>External trigger</i> on page 24)	
	■ Digital pattern detection for inputs and outputs (see <i>Pattern trigger</i> on page 24)	
Input high voltage	2.0 V min	
	5.5 V absolute max	
Input low voltage	0.8 V max	
	−0.5 V absolute min	
	0 V recommended min	
Output high voltage	$4.4 \text{ V min (IOH} = -50 \mu\text{A)}$	
	3.76 V min (IOH = -2.5 mA)	
Output low voltage	$0.1 \text{ V max (IOL} = 50 \mu\text{A})$	
	0.44 V max (IOL = 2.5 mA)	
Output current	±2.5 mA max	

Counter

Table 11. Counter specifications

Parameter	Specification		
Terminal names	CTR0, CTR1		
Number of channels	2 channels		
Resolution	32-bit		
Counter type	FPGA		
Counter input modes	Totalize, Pulse width, Period		
Input type	Schmitt trigger, 33 Ω series resistor, 47 k Ω pull-down to ground		
Input source	CTR0 CTR1		
Scan clock source	Internal input scan clock or external input scan clock (ICLKI pin)		
Trigger source	■ ITRIG (see External trigger on page 24)		
	■ Digital pattern detection (see <i>Pattern trigger</i> on page 24)		
Counter read clock	Internal or external input scan clock up to 200 kHz		
Period/pulse width resolution	20 ns, 200 ns, 2 μs or 20 μs; software-selectable		
Input high voltage	2.2 V min, 5.5 V max		
Input low voltage	1.5 V max, -0.5 V min		
Schmitt trigger hysteresis	0.4 V min, 1.2 V max		
Input frequency	50 MHz, max		
Schmitt trigger hysteresis	0.76 V typ		
	0.4 V min		
	1.2 V max		
Input high voltage threshold	1.74 V typ		
	1.3 V min		
	2.2 V max		
Input low voltage threshold	0.98 V typ		
	0.6 V min		
	1.5 V max		
Input low voltage limit	−0.5 V absolute min		
	0 V recommended min		

Quadrature inputs

Table 12. Quadrature input specifications

Parameter	Specification	
Terminal names	ENC0A, ENC0B, ENC0Z; ENC1A, ENC1B, ENC1Z	
Number of encoders	2	
Signals per encoder	A, B and Z	
Resolution	20 ns	
Maximum frequency	50 MHz	
Minimum pulse width	10 ns	
De-bounce function	None	
Scan clock source	Internal input scan clock or external input scan clock (ICLKI pin)	
Trigger source	■ ITRIG (see External trigger on page 24)	
	■ Digital pattern detection (see <i>Pattern trigger</i> on page 24)	
Input high voltage	2.2 V min, 5.5 V max	
Input low voltage	1.5 V max, -0.5 V min	
Absolute maximum input voltage	5.5 V	

Timer

Table 13. Timer specifications

Parameter	Specification
Terminal name	TMR0, TMR1
Timer type	PWM output with count, period, delay, and pulse width registers
Output value	Default state is idle low with pulses high, software-selectable output invert
Trigger source	OTRIG (see External trigger on page 24)
Internal clock frequency	100 MHz
Register widths	32-bit
High pulse width	10 ns min
Low pulse width	10 ns min
Output high voltage	$4.4 \text{ V min (IOH} = -50 \mu\text{A})$
	3.76 V min (IOH = -2.5 mA)
Output low voltage	$0.1 \text{ V max (IOL} = 50 \mu\text{A})$
	0.44 V max (IOL = 2.5 mA)
Output current	±2.5 mA max

External clock input/output

Table 14. External clock I/O specifications

Parameter	Specification	on	
Terminal names	ICLKI, ICLKO		
	OCLKI, OCL	KO	
Terminal types	xCLKI:	Input, active on rising edge	
	xCLKO:	Output, power on default is 0 V, active on rising edge	
Terminal descriptions	xCLKI:	Receives sampling clock from external source	
	xCLKO:	Outputs the internal input scan or internal output scan clock, or the pulse generated from xCLKI when in external clock mode.	
Input clock rate	500 kHz max		
Clock pulse width	xCLKI:	400 ns min	
	xCLKO:	400 ns min	
Input type	Schmitt trigger, 33 Ω series resistor, 47 k Ω pull-down to ground		
Schmitt trigger hysteresis	0.4 V to 1.2 V		
Input high voltage	2.2 V min	· · · · · · · ·	
	5.5 V absolut	e max	
Input low voltage	1.5 V max		
	−0.5 V absolu	-0.5 V absolute min	
	0 V recomme	ended min	
Output high voltage	$4.4 \text{ V min (IOH} = -50 \mu\text{A})$		
	3.76 V min (I	OH = -2.5 mA	
Output low voltage	0.1 V max (IO	• *	
	0.44 V max (IOL = 2.5 mA)	
Output current	±2.5 mA max		

External trigger

Table 15. External trigger specifications

Parameter	Specification
Trigger source	ITRIG for inputs, OTRIG for outputs
Trigger mode	Software programmable for edge or level sensitive, rising or falling edge, high or low level. Power on default is edge sensitive, rising edge.
Trigger latency	1 μs + 1 clock cycle max
Trigger pulse width	100 ns min
Input type	Schmitt trigger, 33 Ω series resistor and 49.9 k Ω pull-down to ground
Schmitt trigger hysteresis	0.4 V to 1.2 V
Input high voltage	2.2 V min
	5.5 V absolute max
Input low voltage	1.5 V max
	−0.5 V absolute min
	0 V recommended min

Pattern trigger

Table 16. Pattern trigger specifications

Parameter	Specification
Trigger source	DIO0 – DIO3
Trigger types	Above pattern, Below pattern, Equal pattern, or Not equal pattern
Trigger stability	Digital port must be stable for 50 ns to be recognized as a pattern
Trigger bit width	Up to 4, adjustable through bitmask
Trigger latency	Up to 1 scan period

Memory

Table 17. Memory specifications

Parameter	Specification
Data FIFO	4 kS analog input/2 kS analog output
Non-volatile memory	32 KB (28 KB firmware storage, 4 KB calibration/user data)

Power

Table 18. Power specifications

Parameter	Condition	Specification
Supply current (Note 3)	Quiescent current	305 mA
+VO user output voltage range (Note 4)	Available at connector pin 13	4.5 V min to 5.25 V max
+VO user output current	Available at connecter pin 13	10 mA max

Note 3: This is the total quiescent current requirement for the device that includes up to 10 mA for the status LED. This does not include any potential loading of the digital I/O bits, +VO terminal, or the AOUTx outputs.

Note 4: The +4.5 V min limit includes the +VO 10 mA load, it does not include any potential loading of the digital I/O bits or the AOUTx outputs.

USB

Table 19. USB specifications

Parameter	Specification
USB device type	USB 2.0 (high-speed)
Device compatibility	USB 1.1, USB 2.0, USB 3.0
USB cable type	A-B cable, UL type AWM 2725 or equivalent. (Min 24 AWG VBUS/GND, min 28 AWG D+/D-)
USB cable length	3 m (9.84 ft) max

Environmental

Table 20. Environmental specifications

Parameter	Specification		
Operating temperature range	0 °C to 55 °C max		
Storage temperature range	−40 °C to 85 °C max		
Humidity	0% to 90% non-condensing max		

Mechanical

Table 21. Mechanical specifications

Parameter	Specification		
Dimensions (L \times W \times H)	127 × 89.9 × 35.6 mm (5.00 × 3.53 × 1.40 in.)		
User connection length	3 m (9.84 ft) max		

Screw terminal connector

Table 22. Screw terminal connector specifications

Parameter	Specification	
Connector type	Screw terminal	
Wire gauge range	16 AWG to 30 AWG	

Differential mode pinout

Table 23. 8-channel differential mode pinout

Terminal			Terminal		
#	Label	Use	#	Label	Use
1	CH0H	Al channel 0 HI	29	CH7L	Al channel 7 LO
2	CH0L	Al channel 0 LO	30	CH7H	Al channel 7 HI
3	AGND	Analog ground	31	AGND	Analog ground
4	CH1H	Al channel 1 HI	32	CH6L	Al channel 6 LO
5	CH1L	Al channel 1 LO	33	CH6H	Al channel 6 HI
6	AGND	Analog ground	34	AGND	Analog ground
7	CH2H	Al channel 2 HI	35	CH5L	Al channel 5 LO
8	CH2L	Al channel 2 LO	36	CH5H	Al channel 5 HI
9	AGND	Analog ground	37	AGND	Analog ground
10	CH3H	Al channel 3 HI	38	CH4L	Al channel 4 LO
11	CH3L	Al channel 3 LO	39	CH4H	Al channel 4 HI
12	AGND	Analog ground	40	AGND	Analog ground
13	+VO	+5V power output	41	AOUT0	AO channel 0
14	AGND	Analog ground	42	AOUT1	AO channel 1
15	GND	Digital Ground	43	AGND	Analog ground
16	TMR0	Timer 0 output	44	GND	Digital Ground
17	TMR1	Timer 1 output	45	DIO0	DIO channel 0
18	ICLKO	Input scan clock output	46	DIO1	DIO channel 1
19	OCLKO	Output scan clock output	47	GND	Digital Ground
20	GND	Digital ground	48	DIO2	DIO channel 2
21	ICLKI	Input scan clock input	49	DIO3	DIO channel 3
22	OCLKI	Output scan clock input	50	GND	Digital Ground
23	ITRIG	Input Trigger	51	CTR0	Counter 0 input
24	OTRIG	Output Trigger	52	CTR1	Counter 1 input
25	GND	Digital ground	53	GND	Digital ground
26	ENC1A	Encoder 1 Input A	54	ENC0A	Encoder 0 Input A
27	ENC1B	Encoder 1 Input B	55	ENC0B	Encoder 0 Input B
28	ENC1Z	Encoder 1 Input Z	56	ENC0Z	Encoder 0 Input Z

Single-ended mode pinout

Table 24. 16-channel single-ended mode pinout

Terminal				Terminal		
#	Label	Use	#	Label	Use	
1	CH0H	Al channel 0 HI	29	NC	No connection	
2	NC	No connection	30	CH7H	Al channel 7 HI	
3	AGND	Analog ground	31	AGND	Analog ground	
4	CH1H	Al channel 1 HI	32	NC	No connection	
5	NC	No connection	33	CH6H	Al channel 6 HI	
6	AGND	Analog ground	34	AGND	Analog ground	
7	CH2H	Al channel 2 HI	35	NC	No connection	
8	NC	No connection	36	CH5H	Al channel 5 HI	
9	AGND	Analog ground	37	AGND	Analog ground	
10	СНЗН	Al channel 3 HI	38	NC	No connection	
11	NC	No connection	39	CH4H	Al channel 4 HI	
12	AGND	Analog ground	40	AGND	Analog ground	
13	+VO	+5V power output	41	AOUT0	AO channel 0	
14	AGND	Analog ground	42	AOUT1	AO channel 1	
15	GND	Digital Ground	43	AGND	Analog ground	
16	TMR0	Timer 0 output	44	GND	Digital Ground	
17	TMR1	Timer 1 output	45	DIO0	DIO channel 0	
18	ICLKO	Input scan clock output	46	DIO1	DIO channel 1	
19	OCLKO	Output scan clock output	47	GND	Digital Ground	
20	GND	Digital ground	48	DIO2	DIO channel 2	
21	ICLKI	Input scan clock input	49	DIO3	DIO channel 3	
22	OCLKI	Output scan clock input	50	GND	Digital Ground	
23	ITRIG	Input Trigger	51	CTR0	Counter 0 input	
24	OTRIG	Output Trigger	52	CTR1	Counter 1 input	
25	GND	Digital ground	53	GND	Digital ground	
26	ENC1A	Encoder 1 Input A	54	ENC0A	Encoder 0 Input A	
27	ENC1B	Encoder 1 Input B	55	ENC0B	Encoder 0 Input B	
28	ENC1Z	Encoder 1 Input Z	56	ENC0Z	Encoder 0 Input Z	

EU Declaration of ConformityAccording to ISO/IEC 17050-1:2010

Manufacturer: Measurement Computing Corporation

Address: 10 Commerce Way

Norton, MA 02766

USA

Product Category: Electrical equipment for measurement, control and laboratory use.

Date and Place of Issue: March 23, 2017, Norton, Massachusetts USA

Test Report Number: EMI6990.17

Measurement Computing Corporation declares under sole responsibility that the product

USB-1808X

is in conformity with the relevant Union Harmonization Legislation and complies with the essential requirements of the following applicable European Directives:

Electromagnetic Compatibility (EMC) Directive 2014/30/EU

Low Voltage Directive 2014/35/EU

RoHS Directive 2011/65/EU

Conformity is assessed in accordance to the following standards:

EMC:

Emissions:

- EN 61326-1:2013 (IEC 61326-1:2012), Class A
- EN 55011: 2009 + A1:2010 (IEC CISPR 11:2009 + A1:2010), Group 1, Class A

Immunity:

- EN 61326-1:2013 (IEC 61326-1:2012), Controlled EM Environments
- EN 61000-4-2:2008 (IEC 61000-4-2:2008)
- EN 61000-4-3 :2010 (IEC61000-4-3:2010)

Safety:

■ EN 61010-1 (IEC 61010-1)

Environmental Affairs:

Callagrage

Articles manufactured on or after the Date of Issue of this Declaration of Conformity do not contain any of the restricted substances in concentrations/applications not permitted by the RoHS Directive.

Carl Haapaoja, Director of Quality Assurance

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